

<b>Notice of References Cited</b>	Application/Control No. 09/451,289	Applicant(s)/Patent Under Reexamination YAMAGISHI, YOICHI	
	Examiner James M Hannett	Art Unit 2612	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,483,541	11-2002	Yonemoto et al.	348/302
	B	US-4,839,735	06-1989	Kyomasu et al.	348/297
	C	US-6,166,769	12-2000	Yonemoto et al.	348/308
	D	US-6,061,092	05-2000	Bakhle et al.	348/243
	E	US-6,563,536	05-2003	Rashkovskiy et al.	348/243
	F	US-5,719,625	02-1998	Tani, Nobuhiro	348/241
	G	US-4,839,729	06-1989	Ando et al.	348/241
	H	US-6,456,326	09-2002	Fossum et al.	348/308
	I	US-5,937,218	08-1999	Amano et al.	396/311
	J	US-6,177,958	01-2001	Anderson, Eric	348/362
	K	US-6,295,415	09-2001	Kashiyama et al.	396/222
	L	US-5,194,960	03-1993	Ota, Yoshitaka	348/362
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

